



RF EXPOSURE REPORT

REPORT NO.: SA131112E03

MODEL NO.: xPED-8006L2-3CR

FCC ID: MQT-8006L23CR

RECEIVED: Nov. 12, 2013

TESTED: Nov. 24, 2013

ISSUED: Dec. 13, 2013

APPLICANT: XAC AUTOMATION CORP.

ADDRESS: 4F, No. 30, INDUSTRY E. RD. IX,
SCIENCE-BASED INDUSTRIAL
PARK,HSINCHU,TAIWAN

ISSUED BY : Bureau Veritas Consumer Products Services
(H.K.) Ltd., Taoyuan Branch Hsin Chu
Laboratory

LAB ADDRESS : No. 81-1, Lu Liao Keng, 9th Ling, Wu Lung
Tsuen, Chiung Lin Hsiang, Hsin Chu Hsien 307,
Taiwan, R.O.C.

TEST LOCATION (1): No. 81-1, Lu Liao Keng, 9th Ling,Wu Lung
Tsuen, Chiung Lin Hsiang, Hsin Chu Hsien 307,
Taiwan, R.O.C.

TEST LOCATION (2): No. 49, Ln. 206, Wende Rd., Shangshan Tsuen,
Chiung Lin Hsiang, Hsin Chu Hsien 307, Taiwan,
R.O.C.

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RELEASE CONTROL RECORD


ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
SA131112E03	Original release	Dec. 13, 2013



1.CERTIFICATION

PRODUCT: PINPAD
BRAND NAME: XAC
MODEL NO.: xPED-8006L2-3CR
TEST SAMPLE: ENGINEERING SAMPLE
APPLICANT: XAC AUTOMATION CORP.
TESTED: Nov. 24, 2013
STANDARDS: FCC Part 2 (Section 2.1091)
FCC OET Bulletin 65, Supplement C (01-01)
IEEE C95.1

The above equipment (Model: xPED-8006L2-3CR) has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

PREPARED BY :  , **DATE:** Dec. 13, 2013
(Claire Kuan, Specialist)

APPROVED BY :  , **DATE:** Dec. 13, 2013
(May Chen, Manager)

2. EVALUATION RESULT

Following FCC KDB 447498 D01 “General SAR test exclusion guidance”

The corresponding SAR Exclusion Threshold condition, listed below:

- 1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

$$\frac{[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}]}{\leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, 16}}$$
 where
 - $f(\text{GHz})$ is the RF channel transmit frequency in GHz
 - Power and distance are rounded to the nearest mW and mm before calculation
 - The result is rounded to one decimal place for comparison
 The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.
- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:
 - a) [Threshold at 50 mm in step 1) + (test separation distance - 50 mm) · (f(MHz)/150)] mW, at 100MHz to 1500 MHz
 - b) [Threshold at 50 mm in step 1) + (test separation distance - 50 mm) · 10] mW at > 1500 MHz and ≤ 6 GHz
- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.
 - a) The threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(\text{MHz}))]$ for test separation distances > 50 mm and < 200 mm.
 - b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for test separation distances ≤ 50 mm.
 - c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.

Smallest distance from the antenna and radiating structures or outer surface of the device

The minimum test separation distance is determined by the smallest distance from the antenna and radiating structures or outer surface of the device, according to the host form factor, exposure conditions and platform requirements, to any part of the body or extremity of a user or bystander. (See below figure)

3. SAR TEST EXCLUSION THRESHOLDS

Smallest distance from the antenna and radiating structures or outer surface of the device

The minimum test separation distance is determined by the smallest distance from the antenna and radiating structures or outer surface of the device, according to the host form factor, exposure conditions and platform requirements, to any part of the body or extremity of a user or bystander. (See below figure)





RFID Power Table

Mode	Frequency (MHz)	Electric field (dBuV/m) @3m	EIRP (dBm)
RFID	13.56	65.9	-29.3

Field strength is then converted to EIRP as follows:

(i) $EIRP = ((E*d)^2) / 30$

where:

E is the field strength in V/m;

d is the measurement distance in meters;

EIRP is the equivalent isotropically radiated power in watts.

(ii) Working in dB units, the above equation is equivalent to: $EIRP[dBm] = E[dB\mu V/m] + 20 \log(d[meters]) - 104.77$

(iii) Or, if d is 3 meters: $EIRP[dBm] = E[dB\mu V/m] - 95.2$

SAR Test Exclusion Thresholds (RFID Mode)

Frequency (MHz)	Max. Power (mW)* ¹	Min. test separation distance (mm)	SAR test exclusion power thresholds * ² (mW)	Result
13.56	0.001175	≤ 50 mm	593	Pass

*¹ Max. power obtained from maximum EIRP.

*² Calculate SAR test exclusion thresholds from “ 3) ” formulas. (base on 10-g extremity SAR exclusion thresholds)

Conclusion

Since Source-base time average power is below SAR test exclusion power thresholds, the SAR evaluation is not required.

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